AO6701 /MC6701

P-Channel 20-V (D-S) MOSFET With Schottky Diode

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $r_{DS(on)}$ and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

- Low r_{DS(on)} provides higher efficiency and extends battery life
- Low thermal impedance copper leadframe TSOP-6 saves board space
- Fast switching speed
- High performance trench technology

MOSFET PRODUCT SUMMARY							
V _{DS} (V)	r _{DS(on)} (OHM)	I _D (A)					
-20	$0.130 @V_{CS} = -4.5V$	±2.5					
	$0.190 @V_{CS} = -2.5V$	±1.9					

SCHOTTKY PRODUCT SUMMARY							
V _{KA} (V)	V _f (V) Diode Forward Voltage	I _F (A)					
20	0.48V@1.0A	1.0					
	TSOP-6 Top View S						

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ABSOLUTE MAXIMUM RATINGS (T _A = 25 $^{\circ}$ C UNLESS OTHERWISE NOTED)								
Parameter					Symbol	Maximum	Units	
Drain-Source Voltage (MOSFET)					V _{DS}	-20		
Reverse Voltage (Schottky)					VKA	20	V	
Gate-Source Voltage (MOSFET)					Vas	±8		
Continuous Drain Current (T _J =150°C) (MOSFET) ^a $T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$			25°C	ID	±2.5			
			70°C	10	±1.9			
Pulsed Drain Current (MOSFET) ^b					I _{DM}	±10	А	
Continuous Source Current (MOSFET Diode Conduction) ^a					Is	-1.6		
Average Forward Current (Schottky)					$I_{\rm F}$	0.5		
Pulsed Forward Current (Schottky)					\mathbf{I}_{FM}	8		
Maximum Power Dissipation (MOS	FFT) ^a		TA	25°C		1.15		
			T _A =	70°C	PD	0.7	w	
			T _A ≓	25°C	гD	1.0	vv	
Maximum Power Dissipation (Schottky) ^a $T_A=70$				70°C		0.6		
Operating Junction and Storage Temperature Range					TJ, Tstg	-55 to 150	°C	
THERMAL RESISTANCE RATI	NGS							
Parameter Symbol]	Гур	Max			
Maximum Junction-to-Ambient ^a	t <= 10 sec	R _{thJA}			93	110	°C/W	
	Steady State				130	150	C/ W	

Notes

a. Surface Mounted on 1" x 1" FR4 Board.

b. Pulse width limited by maximum junction temperature

MOSFET SPECIFICATIONS ($T_A = 25^{\circ}$ C UNLESS OTHERWISE NOTED)								
Parameter	Symbol	Test Conditions	Limits			Unit		
Falaitetei	Symbol		Min	Тур	Max			
Static								
Gate-Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \text{ uA}$	-0.4					
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = +/-8 V$			±100	nA		
Zero Gate Voltage Drain Ourrent	haa	V_{DS} = -16 V, V_{GS} = 0 V			-1	υA		
	DSS	V_{DS} = -16 V, V_{GS} = 0 V, T_{J} = 55°C			-10	un		
On-State Drain Current ^A	I _{D(on)}	V_{DS} = -5 V, V_{GS} = -4.5 V	-5			А		
Drain-Source On-State Resistance ^A	r	V_{GS} = -4.5 V, I _D = -2.5 A			0.130	Ω		
Diarrisource Oristate Resistance	r _{DS(on)}	V_{GS} = -2.5 V, I_D = -1.9 A			0.190	12		
Forward Tranconductance ^A	9 fs	$V_{DS} = -5 V$, $I_{D} = -2.5 A$		3		S		
Diode Forward Voltage	V _{SD}	$I_{\rm S}$ = -1.6 A, $V_{\rm CS}$ = 0 V		-0.70		V		
Dynamic ^b						•		
Total Gate Charge	Qg			6.0				
Gate-Source Charge	Q _{gs}	$V_{DS} = -5 V$, $V_{CS} = -4.5 V$, $I_{D} = -2.5 A$		0.80		nC		
Gate-Drain Charge	Q _{gd}	I _D = -23A		1.30		1		
Tum-On Delay Time	t _{d(on)}			6.5				
Rise Time	t _r	$V_{DD} = -5 V$, $R_{L} = 5 OHM$,		20				
Tum-Off Delay Time	t _{d(off)}	V_{GEN} = -4.5 V, R_{G} = 6 OHM		31		ns		
Fall-Time	t _f			21				

SCHOTTKY SPECIFICATIONS ($T_A = 25^{\circ}C$ UNLESS OTHERWISE NOTED)								
Parameter	Symbol	Test Conditions		Unit				
Farameter	Symbol	Test Conditions	Min	Тур	Max	Unit		
Forward Voltage Drop	VF	I _F = 0.5 A			0.48	V		
Forward Voltage Drop	۷F	I _F = 0.5 A, T _J = 125 ^o C			0.4	V		
		V _r = 30 V			0.1			
Maximum Reverse Leakage Current	l _m	$V_r = 30 V, T_J = 75^{\circ}C$		1	mA			
		$V_r = 30 V, T_J = 125^{\circ}C$			10	1		
Junction Capacitance	CT	V _r = 10 V		31		pF		

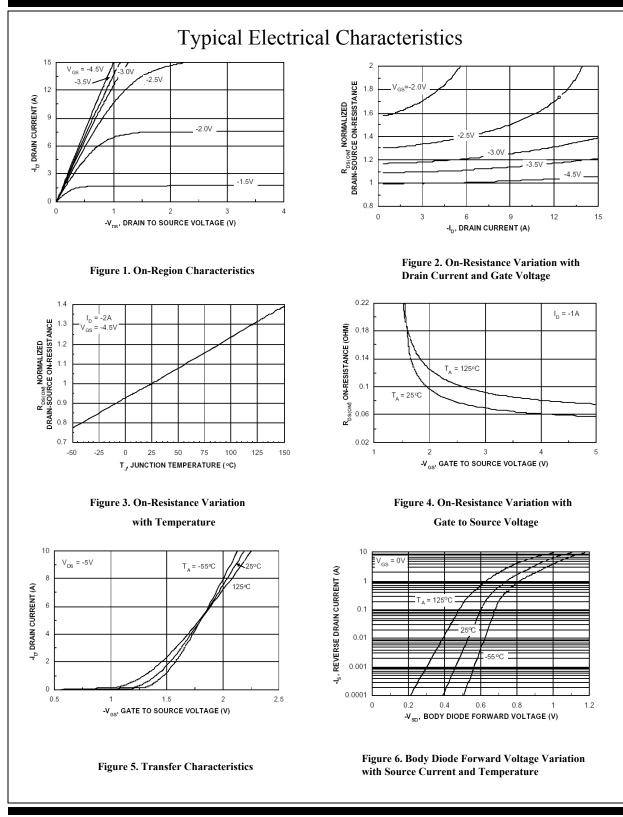
Notes

a. Pulse test: $PW \le 300$ us duty cycle $\le 2\%$.

b. Guaranteed by design, not subject to production testing.

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Freescale



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f = 1 MHz V_{GS} = 0 V

20

Typical Electrical Characteristics 1000 = -3.5A -5\ I, 10V 68, GATE-SOURCE VOLTAGE (V) Ciss 800 15 CAPACITANCE (pF) 3 600 2 400 Coss 1 200 7 0 0 0 2 8 1 3 4 5 6 7 9 0 5 10 15 Q d GATE CHARGE (nC) -VDS, DRAIN TO SOURCE VOLTAGE (V) Figure 7. Gate Charge Characteristic 100 5 LIMIT R_{DS(ON)} 100µs 4 . 10 l0m• 1

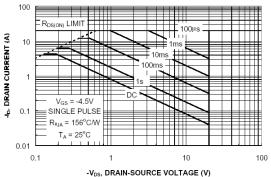
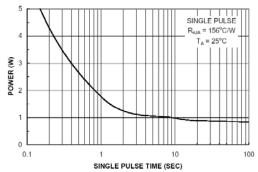
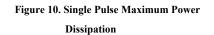
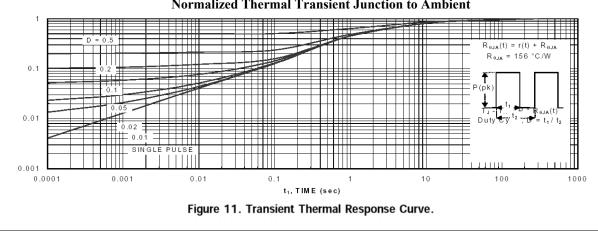


Figure 9. Maximum Safe Operating Area

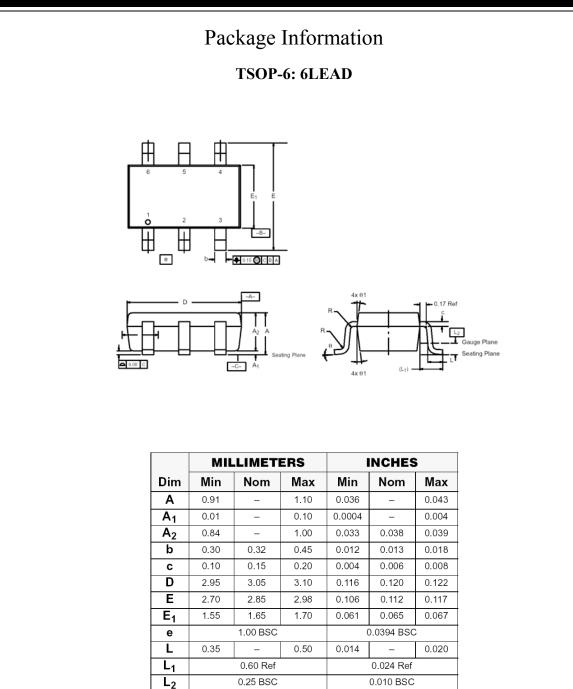
Figure 8. Capacitance Characteristic







Normalized Thermal Transient Junction to Ambient



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8°

0.004

0°

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4°

7° Nom

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8°

R

θ

 θ_1

0.10

0°

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4°

7° Nom